

FEATURES

- 1.5 pF off capacitance
- 0.5 pC charge injection
- 33 V supply range
- 120 Ω on resistance
- Fully specified at ± 15 V/+12 V
- 3 V logic-compatible inputs
- Rail-to-rail operation
- Break-before-make switching action
- 16-lead TSSOP, 20-lead TSSOP, and 4 mm \times 4 mm LFCSP
- Typical power consumption (<0.03 μ W)

APPLICATIONS

- Audio and video routing
- Automatic test equipment
- Data acquisition systems
- Battery-powered systems
- Sample-and-hold systems
- Communication systems

GENERAL DESCRIPTION

The [ADG1233](#) and [ADG1234](#) are monolithic *i*CMOS[®] analog switches comprising three independently selectable single-pole, double throw SPDT switches and four independently selectable SPDT switches, respectively.

All channels exhibit break-before-make switching action preventing momentary shorting when switching channels. An \overline{EN} input on the [ADG1233](#) and [ADG1234](#) enables or disables the device. When disabled, all channels are switched off.

The *i*CMOS (industrial-CMOS) modular manufacturing process combines a high voltage complementary metal-oxide semiconductor (CMOS) and bipolar technologies. It enables the development of a wide range of high performance analog ICs capable of 33 V operation in a footprint that no other generation of high voltage devices has been able to achieve.

Rev. D

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FUNCTIONAL BLOCK DIAGRAMS

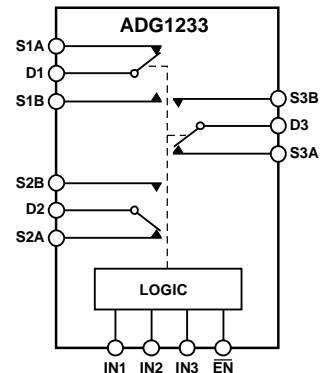


Figure 1.

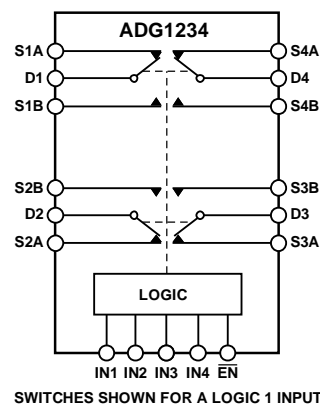


Figure 2.

Unlike analog ICs using conventional CMOS processes, *i*CMOS components can tolerate high supply voltages while providing increased performance, dramatically lowered power consumption, and reduced package size.

The ultralow capacitance and charge injection of these multiplexers make them ideal solutions for data acquisition and sample-and-hold applications, where low glitch and fast settling are required.

Fast switching speed coupled with high signal bandwidth make the devices suitable for video signal switching. *i*CMOS construction ensures ultralow power dissipation, making the devices ideally suited for portable and battery-powered instruments.

PRODUCT HIGHLIGHTS

1. 1.5 pF off capacitance (± 15 V supply).
2. 0.5 pC charge injection.
3. 3 V logic-compatible digital input, $V_{IH} = 2.0$ V, $V_{IL} = 0.8$ V.
4. 16-lead TSSOP, 20-lead TSSOP, and 4 mm \times 4 mm LFCSP.

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REVISION HISTORY

8/2016—Rev. C to Rev. D

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Updated Outline Dimensions	17

3/2016—Rev. B to Rev. C

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2/2009—Rev. A to Rev. B

Change to I _{DD} Parameter, Table 1	4
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8/2006—Rev. 0 to Rev. A

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1/2006—Revision 0: Initial Version

SPECIFICATIONS

DUAL SUPPLY

$V_{DD} = +15\text{ V} \pm 10\%$, $V_{SS} = -15\text{ V} \pm 10\%$, GND = 0 V, unless otherwise noted.

Table 1.

Parameter	Y Version ¹			Unit	Test Conditions/Comments
	+25°C	-40°C to +85°C	-40°C to +125°C		
ANALOG SWITCH					
Analog Signal Range			V_{SS} to V_{DD}	V	
On Resistance (R_{ON})	120			Ω typ	$V_S = \pm 10\text{ V}$, $I_S = -1\text{ mA}$; see Figure 24
	190	230	260	Ω max	$V_{DD} = +13.5\text{ V}$, $V_{SS} = -13.5\text{ V}$
On Resistance Match Between Channels (ΔR_{ON})	3.5			Ω typ	$V_S = \pm 10\text{ V}$, $I_S = -1\text{ mA}$
	6	10	12	Ω max	
On Resistance Flatness ($R_{FLAT(ON)}$)	20			Ω typ	$V_S = -5\text{ V}, 0\text{ V}, +5\text{ V}$; $I_S = -1\text{ mA}$
	60	72	79	Ω max	
LEAKAGE CURRENTS					
Source Off Leakage I_S (Off)	± 0.02			nA typ	$V_{DD} = +16.5\text{ V}$, $V_{SS} = -16.5\text{ V}$
	± 0.1	± 0.6	± 1	nA max	$V_D = \pm 10\text{ V}$, $V_S = -10\text{ V}$; see Figure 25
Drain Off Leakage I_D (Off)	± 0.02			nA typ	$V_S = 1\text{ V}/10\text{ V}$, $V_D = 10\text{ V}/1\text{ V}$; see Figure 25
	± 0.1	± 0.6	± 1	nA max	
Channel On Leakage I_D, I_S (On)	± 0.02			nA typ	$V_S = V_D = \pm 10\text{ V}$; see Figure 26
	± 0.2	± 0.6	± 1	nA max	
DIGITAL INPUTS					
Input High Voltage, V_{INH}			2.0	V min	
Input Low Voltage, V_{INL}			0.8	V max	
Input Current					
I_{INL} or I_{INH}	± 0.005			μA typ	$V_{IN} = V_{INL}$ or V_{INH}
			± 0.1	μA max	
Digital Input Capacitance, C_{IN}	3			pF typ	
DYNAMIC CHARACTERISTICS²					
$t_{TRANSITION}$	110			ns typ	$R_L = 300\ \Omega$, $C_L = 35\text{ pF}$
	130	150	170	ns max	$V_S = 10\text{ V}$; see Figure 27
t_{BBM}	25			ns typ	$R_L = 300\ \Omega$, $C_L = 35\text{ pF}$
			10	ns min	$V_{S1} = V_{S2} = +10\text{ V}$; see Figure 28
$t_{ON}(\overline{EN})$	120			ns typ	$R_L = 300\ \Omega$, $C_L = 35\text{ pF}$
	140	170	195	ns max	$V_S = 10\text{ V}$; see Figure 29
$t_{OFF}(\overline{EN})$	40			ns typ	$R_L = 300\ \Omega$, $C_L = 35\text{ pF}$
	45	55	60	ns max	$V_S = 10\text{ V}$; see Figure 29
Charge Injection	0.5			pC typ	$V_S = 0\text{ V}$, $R_S = 0\ \Omega$, $C_L = 1\text{ nF}$; see Figure 30
Off Isolation	-80			dB typ	$R_L = 50\ \Omega$, $C_L = 5\text{ pF}$, $f = 1\text{ MHz}$; see Figure 31
Channel-to-Channel Crosstalk	-85			dB typ	$R_L = 50\ \Omega$, $C_L = 5\text{ pF}$, $f = 1\text{ MHz}$; see Figure 33
Total Harmonic Distortion, THD + N	0.14			% typ	$R_L = 10\text{ k}\Omega$, 5 V rms, $f = 20\text{ Hz}$ to 20 kHz; see Figure 34
-3 dB Bandwidth	900			MHz typ	$R_L = 50\ \Omega$, $C_L = 5\text{ pF}$; see Figure 32
C_S (Off)	1.5			pF typ	$f = 1\text{ MHz}$; $V_S = 0\text{ V}$
	1.7			pF max	$f = 1\text{ MHz}$; $V_S = 0\text{ V}$
C_D (Off)	1.6			pF typ	$f = 1\text{ MHz}$; $V_S = 0\text{ V}$
	1.8			pF max	$f = 1\text{ MHz}$; $V_S = 0\text{ V}$

Parameter	Y Version ¹			Unit	Test Conditions/Comments
	+25°C	-40°C to +85°C	-40°C to +125°C		
C _D , C _S (On)	3.5 4			pF typ pF max	f = 1 MHz; V _S = 0 V f = 1 MHz; V _S = 0 V
POWER REQUIREMENTS					
I _{DD}	0.002		1.0	μA typ μA max	V _{DD} = +16.5 V, V _{SS} = -16.5 V Digital inputs = 0 V or V _{DD}
I _{DD}	260		475	μA typ μA max	Digital inputs = 5 V
I _{SS}	0.002		1.0	μA typ μA max	Digital inputs = 0 V or V _{DD}
I _{SS}	0.002		1.0	μA typ μA max	Digital inputs = 5 V
V _{DD} /V _{SS}			±5/±16.5	V min/max	GND = 0 V

¹ Temperature range for the Y version: -40°C to +125°C.

² Guaranteed by design, not subject to production test.

SINGLE SUPPLY

$V_{DD} = 12\text{ V} \pm 10\%$, $V_{SS} = 0\text{ V}$, $GND = 0\text{ V}$, unless otherwise noted.

Table 2.

Parameter	Y Version ¹			Unit	Test Conditions/Comments
	+25°C	−40°C to +85°C	−40°C to +125°C		
ANALOG SWITCH					
Analog Signal Range			0 to V_{DD}	V	
On Resistance (R_{ON})	300			Ω typ	$V_S = 0\text{ V}$ to 10 V , $I_S = -1\text{ mA}$; see Figure 24
On Resistance Match Between Channels (ΔR_{ON})	475	567	625	Ω max	$V_{DD} = 10.8\text{ V}$, $V_{SS} = 0\text{ V}$
	5			Ω typ	$V_S = 0\text{ V}$ to 10 V , $I_S = -1\text{ mA}$
On Resistance Flatness ($R_{FLAT(ON)}$)	16	26	27	Ω max	
	60			Ω typ	$V_S = 3\text{ V}$, 6 V , 9 V , $I_S = -1\text{ mA}$
LEAKAGE CURRENTS					
Source Off Leakage I_S (Off)	± 0.02			nA typ	$V_{DD} = 13.2\text{ V}$ $V_S = 1\text{ V}/10\text{ V}$, $V_D = 10\text{ V}/1\text{ V}$; see Figure 25
Drain Off Leakage I_D (Off)	± 0.1 ± 0.02	± 0.6	± 1	nA max nA typ	$V_S = 1\text{ V}/10\text{ V}$, $V_D = 10\text{ V}/1\text{ V}$; see Figure 25
Channel On Leakage I_D, I_S (On)	± 0.1 ± 0.02 ± 0.2	± 0.6	± 1	nA max nA typ nA max	$V_S = V_D = 1\text{ V}$ or 10 V , see Figure 26
DIGITAL INPUTS					
Input High Voltage, V_{INH}			2.0	V min	
Input Low Voltage, V_{INL}			0.8	V max	
Input Current, I_{INL} or I_{INH}	± 0.001			μA typ μA max	$V_{IN} = V_{INL}$ or V_{INH}
Digital Input Capacitance, C_{IN}	2			pF typ	
DYNAMIC CHARACTERISTICS²					
$t_{TRANSITION}$	135			ns typ	$R_L = 300\ \Omega$, $C_L = 35\text{ pF}$ $V_S = 8\text{ V}$; see Figure 27
	170	200	230		
t_{BBM}	45			ns typ	$R_L = 300\ \Omega$, $C_L = 35\text{ pF}$
			10	ns min	$V_{S1} = V_{S2} = 8\text{ V}$; see Figure 28
$t_{ON}(\overline{EN})$	150			ns typ	$R_L = 300\ \Omega$, $C_L = 35\text{ pF}$
	195	230	265		$V_S = 8\text{ V}$; see Figure 29
$t_{OFF}(\overline{EN})$	45			ns typ	$R_L = 300\ \Omega$, $C_L = 35\text{ pF}$
	60	70	75		$V_S = 8\text{ V}$; see Figure 29
Charge Injection	−0.3			pC typ	$V_S = 6\text{ V}$, $R_S = 0\ \Omega$, $C_L = 1\text{ nF}$; see Figure 30
Off Isolation	−80			dB typ	$R_L = 50\ \Omega$, $C_L = 5\text{ pF}$, $f = 1\text{ MHz}$; see Figure 31
Channel-to-Channel Crosstalk	−85			dB typ	$R_L = 50\ \Omega$, $C_L = 5\text{ pF}$, $f = 1\text{ MHz}$; see Figure 33
−3 dB Bandwidth	600			MHz typ	$R_L = 50\ \Omega$, $C_L = 5\text{ pF}$; see Figure 32
C_S (Off)	1.5			pF typ	$f = 1\text{ MHz}$; $V_S = 6\text{ V}$
	1.7			pF max	$f = 1\text{ MHz}$; $V_S = 6\text{ V}$
C_D (Off)	2			pF typ	$f = 1\text{ MHz}$; $V_S = 6\text{ V}$
	2.2			pF max	$f = 1\text{ MHz}$; $V_S = 6\text{ V}$
C_D, C_S (On)	4			pF typ	$f = 1\text{ MHz}$; $V_S = 6\text{ V}$
	4.5			pF max	$f = 1\text{ MHz}$; $V_S = 6\text{ V}$

Parameter	Y Version ¹			Unit	Test Conditions/Comments
	+25°C	-40°C to +85°C	-40°C to +125°C		
POWER REQUIREMENTS					$V_{DD} = 13.2\text{ V}$
I_{DD}	0.002			$\mu\text{A typ}$	Digital inputs = 0 V or V_{DD}
			1.0	$\mu\text{A max}$	
I_{DD}	260			$\mu\text{A typ}$	Digital inputs = 5 V
			475	$\mu\text{A max}$	
V_{DD}			5/16.5	V min/max	$V_{SS} = 0\text{ V}, \text{GND} = 0\text{ V}$

¹ Temperature range for the Y version: -40°C to +125°C

² Guaranteed by design, not subject to production test.

ABSOLUTE MAXIMUM RATINGS

$T_A = 25^\circ\text{C}$, unless otherwise noted.

Table 3.

Parameter	Rating
V_{DD} to V_{SS}	35 V
V_{DD} to GND	-0.3 V to +25 V
V_{SS} to GND	+0.3 V to -25 V
Analog Inputs ¹	$V_{SS} - 0.3\text{ V}$ to $V_{DD} + 0.3\text{ V}$ or 30 mA (whichever occurs first)
Digital Inputs	GND - 0.3 V to $V_{DD} + 0.3\text{ V}$ or 30 mA (whichever occurs first)
Continuous Current, S or D	24 mA
Peak Current, S or D (Pulsed at 1 ms, 10% Duty Cycle Maximum)	100 mA
Operating Temperature Range	
Automotive Temperature Range (Y Version)	-40°C to +125°C
Storage Temperature Range	-65°C to +150°C
Junction Temperature	150°C
TSSOP, θ_{JA} , Thermal Impedance	112°C/W
LFCSP, θ_{JA} , Thermal Impedance	30.4°C/W
Reflow Soldering Peak Temperature, Pb-Free	260°C

¹ Overvoltages at A, $\overline{\text{EN}}$, S, or D are clamped by internal diodes. Current must be limited to the maximum ratings given.

Stresses at or above those listed under Absolute Maximum Ratings may cause permanent damage to the product. This is a stress rating only; functional operation of the product at these or any other conditions above those indicated in the operational section of this specification is not implied. Operation beyond the maximum operating conditions for extended periods may affect product reliability.

Only one absolute maximum rating is applied at any one time.

ESD CAUTION



ESD (electrostatic discharge) sensitive device.

Charged devices and circuit boards can discharge without detection. Although this product features patented or proprietary protection circuitry, damage may occur on devices subjected to high energy ESD. Therefore, proper ESD precautions should be taken to avoid performance degradation or loss of functionality.

PIN CONFIGURATIONS AND FUNCTION DESCRIPTIONS

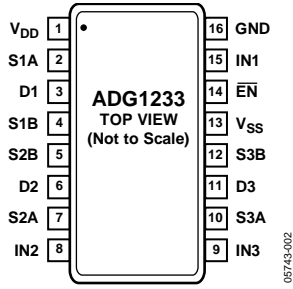


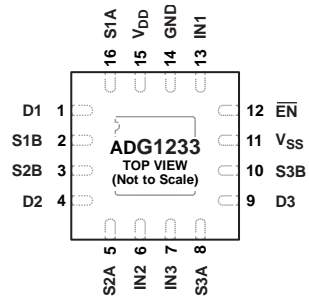
Figure 3. 16-Lead TSSOP Pin Configuration



Figure 4. 20-Lead TSSOP Pin Configuration

Table 4. 16-Lead TSSOP/20-Lead TSSOP Pin Configurations

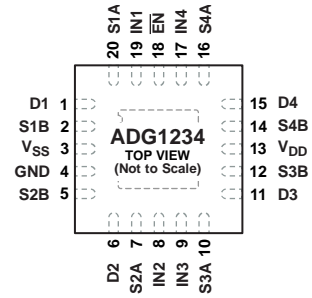
Pin No. ADG1233 16-Lead TSSOP	Pin No. ADG1234 20-Lead TSSOP	Mnemonic
1	16	V _{DD}
2	2	S1A
3	3	D1
4	4	S1B
5	7	S2B
6	8	D2
7	9	S2A
8	10	IN2
9	11	IN3
10	12	S3A
11	13	D3
12	14	S3B
13	5	V _{SS}
14	15	EN
15	1	IN1
16	6	GND
Not applicable	17	S4B
Not applicable	18	D4
Not applicable	19	S4A
Not applicable	20	IN4



- NOTES
1. NC = NO CONNECT. DO NOT CONNECT TO THIS PIN.
 2. THE EXPOSED PAD MUST BE TIED TO SUBSTRATE, V_{SS} .

05743-004

Figure 5. 16-Lead, 4 mm x 4 mm LFCSP Pin Configuration, Exposed Pad Tied to Substrate, V_{SS}



- NOTES
1. THE EXPOSED PAD MUST BE TIED TO SUBSTRATE, V_{SS} .

05743-005

Figure 6. 20-Lead, 4 mm x 4 mm LFCSP Pin Configuration, Exposed Pad Tied to Substrate, V_{SS}

Table 5. 16-Lead LFCSP/20-Lead LFCSP Pin Configurations

Pin No. ADG1233 16-Lead LFCSP	Pin No. ADG1234 20-Lead LFCSP	Mnemonic
1	1	D1
2	2	S1B
3	5	S2B
4	6	D2
5	7	S2A
6	8	IN2
7	9	IN3
8	10	S3A
9	11	D3
10	12	S3B
11	3	V_{SS}
12	18	\overline{EN}
13	19	IN1
14	4	GND
15	13	V_{DD}
16	20	S1A
Not applicable	14	S4B
Not applicable	15	D4
Not applicable	16	S4A
Not applicable	17	IN4

Table 6. **ADG1233/ADG1234** Truth Table

\overline{EN}	INx	Switch xA	Switch xB
1	X	Off	Off
0	0	Off	On
0	1	On	Off

TERMINOLOGY

V_{DD}

Most positive supply potential.

V_{SS}

Most negative power supply potential in dual supplies. In single-supply applications, it can be connected to ground.

GND

Ground (0 V) reference.

R_{ON}

Ohmic resistance between D and S.

ΔR_{ON}

Difference between the R_{ON} of any two channels.

I_S (Off)

Source leakage current when switch is off.

I_D (Off)

Drain leakage current when switch is off.

I_D, I_S (On)

Channel leakage current when switch is on.

V_D, V_S

Analog voltage on Terminal D, Terminal S.

C_S (Off)

Channel input capacitance for off condition.

C_D (Off)

Channel output capacitance for off condition.

C_D, C_S (On)

On switch capacitance.

C_{IN}

Digital input capacitance.

$t_{ON}(\overline{EN})$

Delay time between the 50% and 90% points of the digital input and switch on condition.

$t_{OFF}(\overline{EN})$

Delay time between the 50% and 90% points of the digital input and switch off condition.

$t_{TRANSITION}$

Delay time between the 50% and 90% points of the digital inputs and the switch on condition when switching from one address state to another.

t_{BBM}

Off time measured between the 80% point of both switches when switching from one address state to another.

V_{INL}

Maximum input voltage for Logic 0.

V_{INH}

Minimum input voltage for Logic 1.

I_{INL}, I_{INH}

Input current of the digital input.

I_{DD}

Positive supply current.

I_{SS}

Negative supply current.

Off Isolation

A measure of an unwanted signal coupling through an off channel.

Charge Injection

A measure of the glitch impulse transferred from the digital input to the analog output during switching.

Bandwidth

Frequency at which the output is attenuated by 3 dB.

On Response

Frequency response of the on switch.

THD + N

Ratio of the harmonic amplitude plus noise of the signal to the fundamental.

TYPICAL PERFORMANCE CHARACTERISTICS

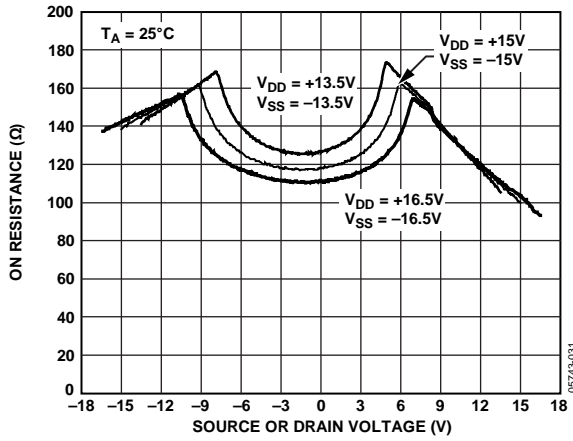


Figure 7. On Resistance as a Function of V_D (V_S) for Dual Supply



Figure 10. On Resistance as a Function of V_D (V_S) for Different Temperatures, Dual Supply

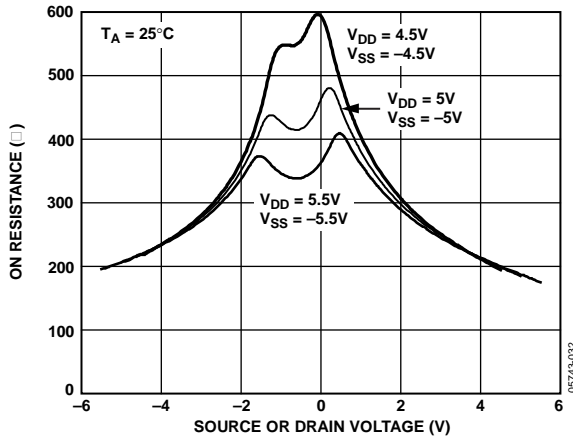


Figure 8. On Resistance as a Function of V_D (V_S) for Dual Supply

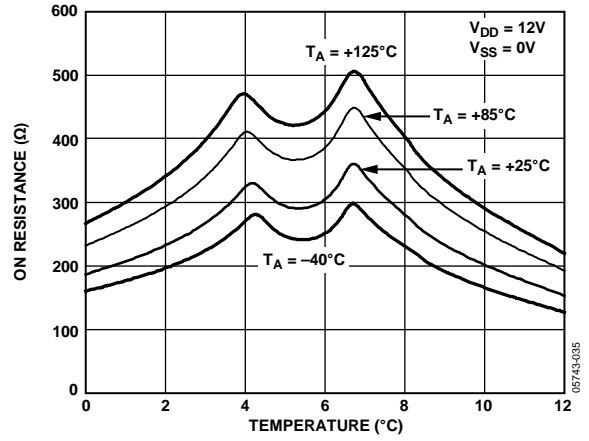


Figure 11. On Resistance as a Function of V_D (V_S) for Different Temperatures, Single Supply

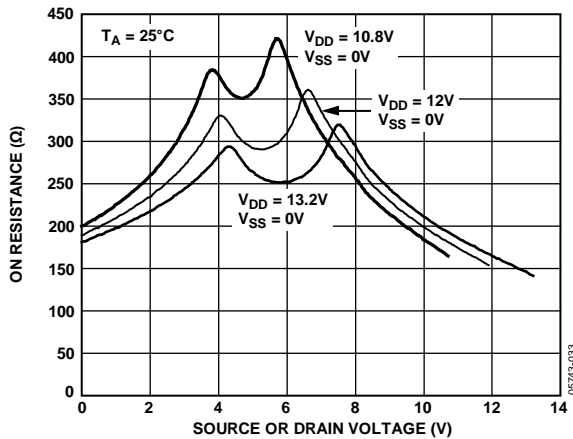


Figure 9. On Resistance as a Function of V_D (V_S) for Single Supply

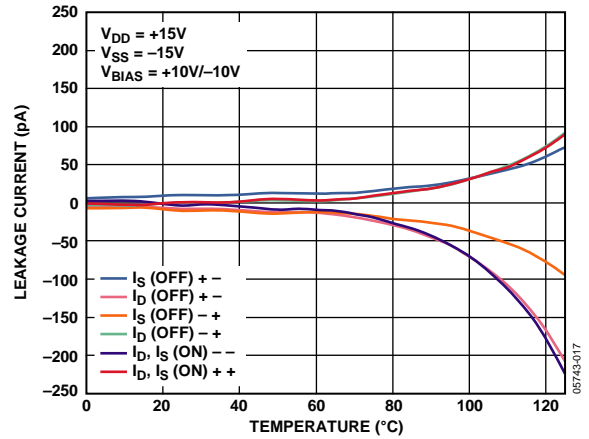


Figure 12. Leakage Currents as a Function of Temperature, Dual Supply



Figure 13. Leakage Currents as a Function of Temperature, Single Supply



Figure 16. $t_{TRANSITION}$ vs. Temperature



Figure 14. I_{DD} vs. Logic Level



Figure 17. Off Isolation vs. Frequency



Figure 15. Charge Injection vs. Source Voltage



Figure 18. Crosstalk vs. Frequency

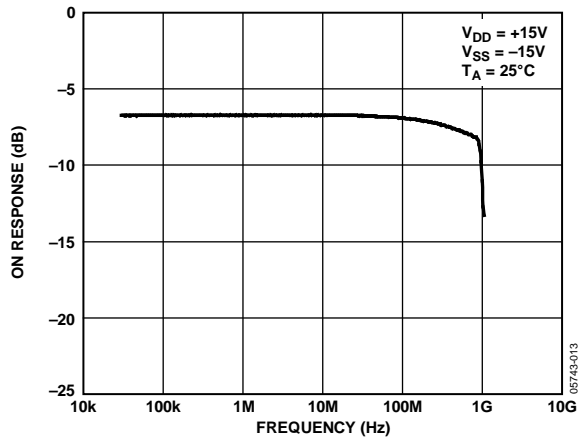


Figure 19. On Response vs. Frequency

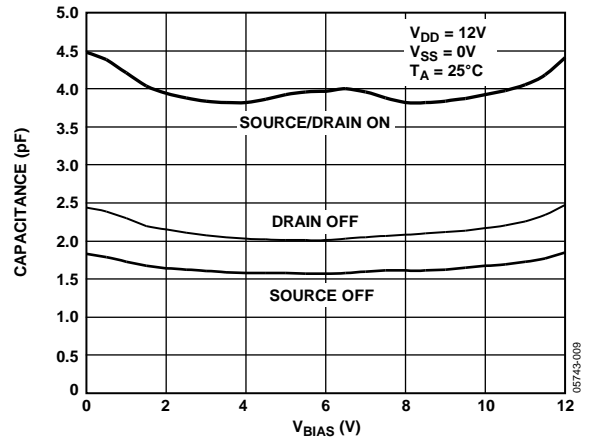


Figure 22. Capacitance vs. Source Voltage for Single Supply



Figure 20. THD + N vs. Frequency



Figure 23. Capacitance vs. Source Voltage for Dual Supply

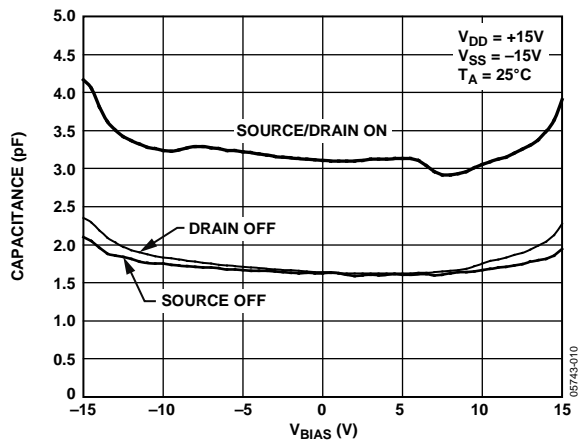


Figure 21. Capacitance vs. Source Voltage for Dual Supply

TEST CIRCUITS



Figure 24. On Resistance



Figure 25. Off Leakage



Figure 26. On Leakage



Figure 27. Switching Timing



Figure 28. Break-Before-Make Delay

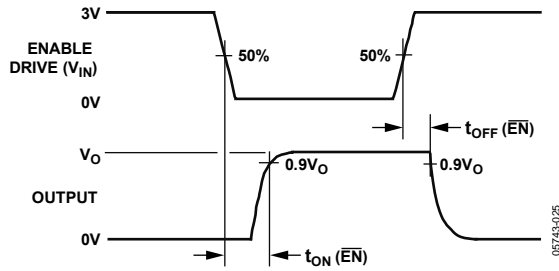


Figure 29. Enable Delay, $t_{ON}(\overline{EN})$, $t_{OFF}(\overline{EN})$

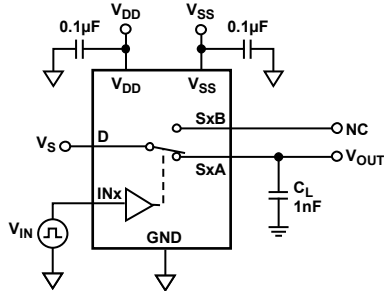


Figure 30. Charge Injection



$$\text{OFF ISOLATION} = 20 \log \frac{V_{OUT}}{V_s}$$

Figure 31. Off Isolation



$$\text{CHANNEL-TO-CHANNEL CROSSTALK} = 20 \log \frac{V_{OUT}}{V_s}$$

Figure 33. Channel-to-Channel Crosstalk



$$\text{INSERTION LOSS} = 20 \log \frac{V_{OUT \text{ WITH SWITCH}}}{V_{OUT \text{ WITHOUT SWITCH}}}$$

Figure 32. Bandwidth



Figure 34. THD + Noise

OUTLINE DIMENSIONS



COMPLIANT TO JEDEC STANDARDS MO-153-AB

Figure 35. 16-Lead Thin Shrink Small Outline Package [TSSOP] (RU-16)

Dimensions shown in millimeters



COMPLIANT TO JEDEC STANDARDS MO-153-AC

Figure 36. 20-Lead Thin Shrink Small Outline Package [TSSOP] (RU-20)

Dimensions shown in millimeters



COMPLIANT TO JEDEC STANDARDS MO-220-WGGC.
 Figure 37. 16-Lead Lead Frame Chip Scale Package [LFCS]
 4 mm × 4 mm Body and 0.75 mm Package Height
 (CP-16-23)
 Dimensions shown in millimeters



COMPLIANT TO JEDEC STANDARDS MO-220-WGGD-1.
 Figure 38. 20-Lead Lead Frame Chip Scale Package [LFCS]
 4 mm × 4 mm Body and 0.75 mm Package Height
 (CP-20-6)
 Dimensions shown in millimeters

ORDERING GUIDE

Model ¹	Temperature Range	Package Description	Package Option
ADG1233YRUZ	-40°C to +125°C	16-Lead Thin Shrink Small Outline Package [TSSOP]	RU-16
ADG1233YRUZ-REEL7	-40°C to +125°C	16-Lead Thin Shrink Small Outline Package [TSSOP]	RU-16
ADG1233YCPZ-REEL7	-40°C to +125°C	16-Lead Lead Frame Chip Scale Package [LFCS]	CP-16-23
ADG1234YRUZ	-40°C to +125°C	20-Lead Thin Shrink Small Outline Package [TSSOP]	RU-20
ADG1234YRUZ-REEL7	-40°C to +125°C	20-Lead Thin Shrink Small Outline Package [TSSOP]	RU-20
ADG1234YCPZ-REEL	-40°C to +125°C	20-Lead Lead Frame Chip Scale Package [LFCS]	CP-20-6
ADG1234YCPZ-REEL7	-40°C to +125°C	20-Lead Lead Frame Chip Scale Package [LFCS]	CP-20-6

¹ Z = RoHS Compliant Part.



Компания «ЭлектроПласт» предлагает заключение долгосрочных отношений при поставках импортных электронных компонентов на взаимовыгодных условиях!

Наши преимущества:

- Оперативные поставки широкого спектра электронных компонентов отечественного и импортного производства напрямую от производителей и с крупнейших мировых складов;
- Поставка более 17-ти миллионов наименований электронных компонентов;
- Поставка сложных, дефицитных, либо снятых с производства позиций;
- Оперативные сроки поставки под заказ (от 5 рабочих дней);
- Экспресс доставка в любую точку России;
- Техническая поддержка проекта, помощь в подборе аналогов, поставка прототипов;
- Система менеджмента качества сертифицирована по Международному стандарту ISO 9001;
- Лицензия ФСБ на осуществление работ с использованием сведений, составляющих государственную тайну;
- Поставка специализированных компонентов (Xilinx, Altera, Analog Devices, Intersil, Interpoint, Microsemi, Aeroflex, Peregrine, Syfer, Eurofarad, Texas Instrument, Miteq, Cobham, E2V, MA-COM, Hittite, Mini-Circuits, General Dynamics и др.);

Помимо этого, одним из направлений компании «ЭлектроПласт» является направление «Источники питания». Мы предлагаем Вам помощь Конструкторского отдела:

- Подбор оптимального решения, техническое обоснование при выборе компонента;
- Подбор аналогов;
- Консультации по применению компонента;
- Поставка образцов и прототипов;
- Техническая поддержка проекта;
- Защита от снятия компонента с производства.



Как с нами связаться

Телефон: 8 (812) 309 58 32 (многоканальный)

Факс: 8 (812) 320-02-42

Электронная почта: org@eplast1.ru

Адрес: 198099, г. Санкт-Петербург, ул. Калинина, дом 2, корпус 4, литера А.